# Low-Voltage CMOS Octal Buffer

# With 5 V–Tolerant Inputs and Outputs (3–State, Non–Inverting)

The 74LVC244A is a high performance, non–inverting octal buffer operating from a 1.2 to 3.6 V supply. High impedance TTL compatible inputs significantly reduce current loading to input drivers while TTL compatible outputs offer improved switching noise performance. A V<sub>I</sub> specification of 5.5 V allows 74LVC244A inputs to be safely driven from 5 V devices. The 74LVC244A is suitable for memory address driving and all TTL level bus oriented transceiver applications.

Current drive capability is 24 mA at the outputs. The Output Enable  $(\overline{OE})$  input, when HIGH, disables the output by placing them in a HIGH Z condition.

#### Features

- Designed for 1.2 V to 3.6 V V<sub>CC</sub> Operation
- 5 V Tolerant Interface Capability With 5 V TTL Logic
- Supports Live Insertion and Withdrawal
- $I_{OFF}$  Specification Guarantees High Impedance When  $V_{CC} = 0 V$
- 24 mA Output Sink and Source Capability
- Near Zero Static Supply Current in All Three Logic States (10 μA) Substantially Reduces System Power Requirements
- ESD Performance:
  - Human Body Model >2000 V
  - ◆ Machine Model >200 V
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant



# **ON Semiconductor®**

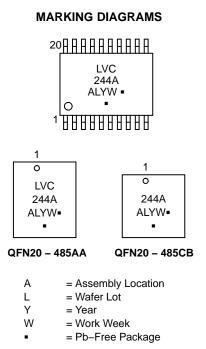
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TSSOP-20 DT SUFFIX CASE 948E

QFN20 MN SUFFIX CASE 485AA



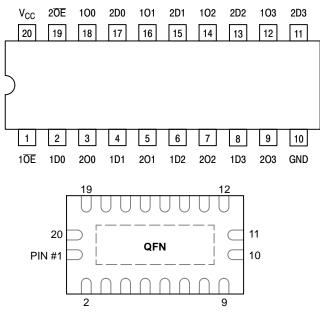


(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 7 of this data sheet.

This document contains information on some products that are still under development. ON Semiconductor reserves the right to change or discontinue these products without notice.



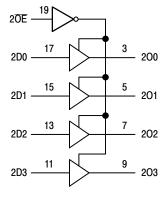


Figure 2. Logic Diagram

Figure 1. Pinout: 20-Lead (Top View)

#### **PIN NAMES**

PINS	FUNCTION
nOE	Output Enable Inputs
1Dn, 2Dn	Data Inputs
10n, 20n	3–State Outputs

#### **TRUTH TABLE**

INP	UTS	OUTPUTS
1 <u>0E</u> 20E	1Dn 2Dn	10n, 20n
L	L	L
L	н	н
Н	Х	Z

H = High Voltage Level

L = Low Voltage Level

Z = High Impedance State

X = High or Low Voltage Level and Transitions are Acceptable For  $I_{CC}$  reasons, DO NOT FLOAT Inputs

#### MAXIMUM RATINGS

Symbol	Parameter	Condition	Value	Unit
V <sub>CC</sub>	DC Supply Voltage		-0.5 to +6.5	V
VI	DC Input Voltage		$-0.5 \le V_1 \le +6.5$	V
Vo	DC Output Voltage	Output in 3-State	$-0.5 \le V_{O} \le +6.5$	V
		Output in HIGH or LOW State (Note 1)	$-0.5 \leq V_O \leq V_{CC} + 0.5$	V
I <sub>IK</sub>	DC Input Diode Current	V <sub>I</sub> < GND	-50	mA
Ι <sub>ΟΚ</sub>	DC Output Diode Current	V <sub>O</sub> < GND	-50	mA
		$V_{O} > V_{CC}$	+50	mA
Ι <sub>Ο</sub>	DC Output Source/Sink Current		±50	mA
Icc	DC Supply Current Per Supply Pin		±100	mA
I <sub>GND</sub>	DC Ground Current Per Ground Pin		±100	mA
T <sub>STG</sub>	Storage Temperature Range		-65 to +150	°C
ΤL	Lead Temperature, 1 mm from Case for 10 Seconds		T <sub>L</sub> = 260	°C
TJ	Junction Temperature Under Bias		T <sub>J</sub> = 135	°C
$\theta_{JA}$	Thermal Resistance (Note 2)		110.7	°C/W
MSL	Moisture Sensitivity	Level 1		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. I<sub>O</sub> absolute maximum rating must be observed.

2. Measured with minimum pad spacing on an FR4 board, using 10 mm-by-1 inch, 2 ounce copper trace no air flow.

#### **RECOMMENDED OPERATING CONDITIONS**

Symbol	Parameter	Min	Тур	Max	Units
V <sub>CC</sub>	Supply Voltage Operating Functional	1.65 1.2		3.6 3.6	V
VI	Input Voltage	0		5.5	V
V <sub>O</sub>	Output Voltage HIGH or LOW State 3–State	0 0		V <sub>CC</sub> 5.5	V
I <sub>OH</sub>	$      HIGH Level Output Current \\ V_{CC} = 3.0 V - 3.6 V \\ V_{CC} = 2.7 V - 3.0 V $			-24 -12	mA
I <sub>OL</sub>	$      LOW Level Output Current \\ V_{CC} = 3.0 V - 3.6 V \\ V_{CC} = 2.7 V - 3.0 V $			24 12	mA
T <sub>A</sub>	Operating Free–Air Temperature	-40		+125	°C
Δt/ΔV	Input Transition Rise or Fall Rate $V_{CC} = 1.65 \text{ V to } 2.7 \text{ V}$ $V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	0 0		20 10	ns/V

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

#### DC ELECTRICAL CHARACTERISTICS

			–40°C to +85°C			–40°C to +125°C			
Symbol	Parameter	Conditions	Min	<b>Typ</b> (Note 3)	Max	Min	<b>Typ</b> (Note 3)	Max	Unit
VIH	HIGH-level input	V <sub>CC</sub> = 1.2 V	1.08	-	-	1.08	-	_	V
	voltage	V <sub>CC</sub> = 1.65 V to 1.95 V	0.65 x V <sub>CC</sub>	-	-	0.65 x V <sub>CC</sub>	-	-	
		$V_{CC}$ = 2.3 V to 2.7 V	1.7	-	-	1.7	-	-	
		$V_{CC}$ = 2.7 V to 3.6 V	2.0	-	_	2.0	-	_	
VIL	LOW-level input	V <sub>CC</sub> = 1.2 V	-	-	0.12	-	-	0.12	V
	voltage	V <sub>CC</sub> = 1.65 V to 1.95 V	-	-	0.35 x V <sub>CC</sub>	-	-	0.35 x V <sub>CC</sub>	
		$V_{CC}$ = 2.3 V to 2.7 V	-	-	0.7	-	-	0.7	
		$V_{CC}$ = 2.7 V to 3.6 V	-	-	0.8	-	-	0.8	
V <sub>OH</sub>	HIGH-level output	$V_{I} = V_{IH} c$	or V <sub>IL</sub>						V
	voltage	$I_{O} = -100 \ \mu\text{A};$ $V_{CC} = 1.65 \ \text{V} \text{ to } 3.6 \ \text{V}$	V <sub>CC</sub> – 0.2	-	-	V <sub>CC</sub> - 0.3	-	_	
		$I_{O} = -4 \text{ mA}; V_{CC} = 1.65 \text{ V}$	1.2	-	_	1.05	-	-	
		$I_{O} = -8 \text{ mA}; V_{CC} = 2.3 \text{ V}$	1.8	-	_	1.65	-	-	
		$I_{O} = -12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	2.2	-	-	2.05	-	-	
		$I_{O} = -18$ mA; $V_{CC} = 3.0$ V	2.4	-	-	2.25	-	-	
		$I_{O} = -24$ mA; $V_{CC} = 3.0$ V	2.2	-	-	2.0	-	-	
VOL	LOW-level output	$V_{I} = V_{IH} c$	or V <sub>IL</sub>						V
	voltage	$I_O = 100 \ \mu\text{A};$ $V_{CC} = 1.65 \ \text{V} \ \text{to} \ 3.6 \ \text{V}$	-	-	0.2	_	-	0.3	
		I <sub>O</sub> = 4 mA; V <sub>CC</sub> = 1.65 V	-	-	0.45	-	-	0.65	
		I <sub>O</sub> = 8 mA; V <sub>CC</sub> = 2.3 V	-	-	0.6	-	-	0.8	
		$I_0 = 12 \text{ mA}; \text{ V}_{CC} = 2.7 \text{ V}$	-	-	0.4	-	-	0.6	
		I <sub>O</sub> = 24 mA; V <sub>CC</sub> = 3.0 V	-	-	0.55	-	-	0.8	
I <sub>I</sub>	Input leakage current	$V_{\rm I}$ = 5.5V or GND $V_{\rm CC}$ = 3.6 V	-	±0.1	±5	-	±0.1	±20	μΑ
I <sub>OZ</sub>	OFF-state output current	VI = VIH or VIL; V <sub>O</sub> = 5.5 V or GND; V <sub>CC</sub> = 3.6 V	-	±0.1	±5	-	±0.1	±20	μΑ
I <sub>OFF</sub>	Power-off leakage current	$V_{\rm I} \mbox{ or } V_{\rm O}$ = 5.5 V; $V_{\rm CC}$ = 0.0 V	-	±0.1	±10	-	±0.1	±20	μΑ
I <sub>CC</sub>	Supply current	$V_{I} = V_{CC} \text{ or GND; } I_{O} = 0 \text{ A;}$ $V_{CC} = 3.6 \text{ V}$	-	0.1	10	-	0.1	40	μΑ
$\Delta I_{CC}$	Additional supply current	per input pin; $V_I = V_{CC} - 0.6 \text{ V}; I_O = 0 \text{ A};$ $V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	-	5	500	-	5	5000	μA

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. All typical values are measured at  $T_A = 25^{\circ}$ C and  $V_{CC} = 3.3$  V, unless stated otherwise.

# 74I VC244A

#### AC ELECTRICAL CHARACTERISTICS (t<sub>R</sub> = t<sub>F</sub> = 2.5 ns)

			-40	)°C to +8	5°C	-40	°C to +12	25°C	
Symbol	Parameter	Conditions	Min	Typ <sup>1</sup>	Мах	Min	Typ1	Max	Unit
t <sub>pd</sub>	Propagation Delay (Note 5)	V <sub>CC</sub> = 1.2 V	-	17.0	-	-	-	-	ns
	nDn to nOn	$V_{CC}$ = 1.65 V to 1.95 V	1.5	6.4	13.7	1.5	-	15.8	
		$V_{CC}$ = 2.3 V to 2.7 V	1.0	3.4	7.1	1.0	-	8.2	
		V <sub>CC</sub> = 2.7 V	1.5	3.4	6.9	1.5	-	9.0	
		$V_{CC}$ = 3.0 V to 3.6 V	1.5	2.9	5.9	1.5	-	7.5	
t <sub>en</sub>	Enable Time (Note 6)	V <sub>CC</sub> = 1.2 V	-	24.0	-	_	-	-	ns
	nOE to nOn	$V_{CC}$ = 1.65 V to 1.95 V	1.5	7.0	17.3	1.5	-	20.0	
		$V_{CC}$ = 2.3 V to 2.7 V	1.5	3.9	9.5	1.5	-	11.0	
		V <sub>CC</sub> = 2.7 V	1.5	4.1	8.6	1.5	-	11.0	
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	1.0	3.2	7.6	1.0	-	9.5	
t <sub>dis</sub>	Disable Time (Note 7)	V <sub>CC</sub> = 1.2 V	-	9.0	-	_	-	-	ns
	nOE to nOn	$V_{CC}$ = 1.65 V to 1.95 V	2.2	4.5	9.8	2.2	-	11.3	
		$V_{CC}$ = 2.3 V to 2.7 V	0.5	3.6	5.5	0.5	-	6.4	
		V <sub>CC</sub> = 2.7 V	1.5	3.3	6.8	1.5	-	8.5	
		$V_{CC}$ = 3.0 V to 3.6 V	1.5	3.1	5.8	1.5	-	7.5	
t <sub>sk(0)</sub>	Output Skew Time (Note 8)		-	-	1	-	-	1.5	ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Typical values are measured at  $T_A = 25^{\circ}C$  and  $V_{CC} = 3.3$  V, unless stated otherwise.

5.  $t_{pd}$  is the same as  $t_{PLH}$  and  $t_{PHL}$ .

6.  $t_{en}$  is the same as  $t_{PZL}$  and  $t_{PZH}$ .

7. t<sub>dis</sub> is the same as t<sub>PLZ</sub> and t<sub>PHZ</sub>.

8. Skew between any two outputs of the same package switching in the same direction. This parameter is guaranteed by design.

#### DYNAMIC SWITCHING CHARACTERISTICS

			T <sub>A</sub> = +25°C			
Symbol	Characteristic	Condition	Min	Тур	Мах	Unit
V <sub>OLP</sub>	Dynamic LOW Peak Voltage (Note 9)			0.8 0.6		V
V <sub>OLV</sub>	Dynamic LOW Valley Voltage (Note 9)			-0.8 -0.6		V

9. Number of outputs defined as "n". Measured with "n-1" outputs switching from HIGH-to-LOW or LOW-to-HIGH. The remaining output is measured in the LOW state.

#### **CAPACITIVE CHARACTERISTICS**

Symbol	Parameter	Condition	Typical	Unit
CIN	Input Capacitance	$V_{CC}$ = 3.3 V, $V_{I}$ = 0 V or $V_{CC}$	4	pF
Соит	Output Capacitance	$V_{CC}$ = 3.3 V, $V_{I}$ = 0 V or $V_{CC}$	5	pF
C <sub>PD</sub>	Power Dissipation Capacitance	Per input; V <sub>I</sub> = GND or	r V <sub>CC</sub>	pF
	(Note 10)	V <sub>CC</sub> = 1.65 V to 1.95 V	6.4	
		V <sub>CC</sub> = 2.3 V to 2.7 V	9.6	
		V <sub>CC</sub> = 3.0 V to 3.6 V	12.5	

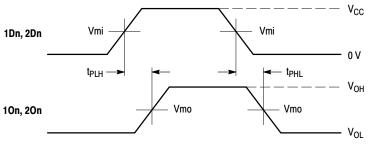
10.  $C_{PD}$  is used to determine the dynamic power dissipation (P<sub>D</sub> in  $\mu$ W).

 $P_D = C_{PD} \times V_{CC}^2 \times fi \times N + \Sigma (C_L \times V_{CC}^2 \times fo)$  where: fi = input frequency in MHz; fo = output frequency in MHz

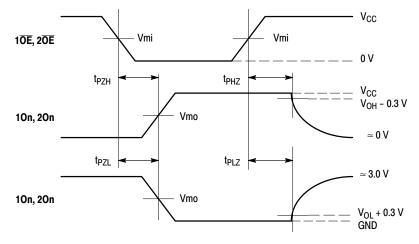
 $C_L$  = output load capacitance in pF  $V_{CC}$  = supply voltage in Volts

N = number of outputs switching

 $\Sigma(C_L \times V_{CC}^2 \times fo) = \text{sum of the outputs.}$ 



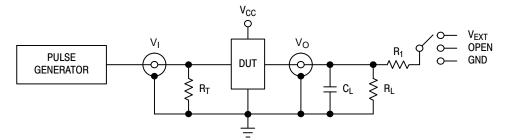




**WAVEFORM 2 – OUTPUT ENABLE AND DISABLE TIMES**  $t_R = t_F = 2.5$  ns, 10% to 90%; f = 1 MHz;  $t_W = 500$  ns

Figure	3. AC	Waveforms
--------	-------	-----------

	V <sub>cc</sub>					
Symbol	3.3 V $\pm$ 0.3 V	2.7 V	V <sub>CC</sub> < 2.7 V			
Vmi	1.5 V	1.5 V	V <sub>CC</sub> /2			
Vmo	1.5 V	1.5 V	V <sub>CC</sub> /2			
V <sub>HZ</sub>	V <sub>OL</sub> + 0.3 V	V <sub>OL</sub> + 0.3 V	V <sub>OL</sub> + 0.15 V			
$V_{LZ}$	V <sub>OH</sub> – 0.3 V	V <sub>OH</sub> – 0.3 V	V <sub>OH</sub> – 015 V			



 $C_L$  includes jig and probe capacitance  $R_T$  =  $Z_{OUT}$  of pulse generator (typically 50  $\Omega)$   $R_1$  =  $R_L$ 

Supply Voltage	Ing	out	Lo	ad		V <sub>EXT</sub>	
V <sub>CC</sub> (V)	VI	t <sub>r</sub> , t <sub>f</sub>	CL	RL	t <sub>PLH</sub> , t <sub>PHL</sub>	t <sub>PLZ</sub> , t <sub>PZL</sub>	t <sub>PHZ</sub> , t <sub>PZH</sub>
1.2	V <sub>CC</sub>	≤ 2 ns	30 pF	1 kΩ	Open	2 x V <sub>CC</sub>	GND
1.65 – 1.95	V <sub>CC</sub>	≤ 2 ns	30 pF	1 kΩ	Open	2 x V <sub>CC</sub>	GND
2.3 – 2.7	V <sub>CC</sub>	≤ 2 ns	30 pF	500 Ω	Open	$2 \times V_{CC}$	GND
2.7	2.7 V	≤ 2.5 ns	50 pF	500 Ω	Open	2 x V <sub>CC</sub>	GND
3 – 3.6	2.7 V	≤ 2.5 ns	50 pF	500 Ω	Open	2 x V <sub>CC</sub>	GND

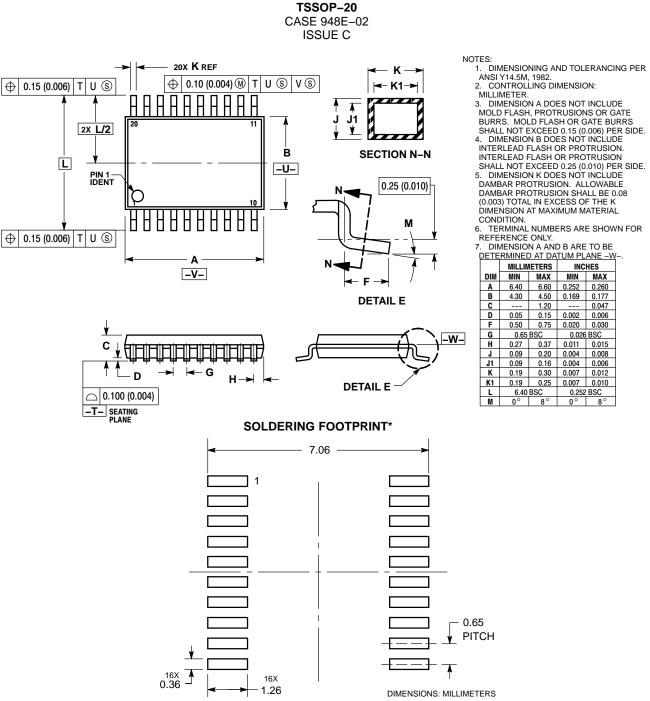
Figure 4. Test Circuit

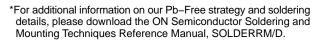
#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
74LVC244ADTR2G	TSSOP-20 (Pb-Free)	2500 / Tape & Reel
74LVC244AMN2TWG (In Development)	QFN20, 2.5x3.5 (Pb-Free)	3000 / Tape & Reel
74LVC244AMNTWG (In Development)	QFN20, 2.5x4.5 (Pb-Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS





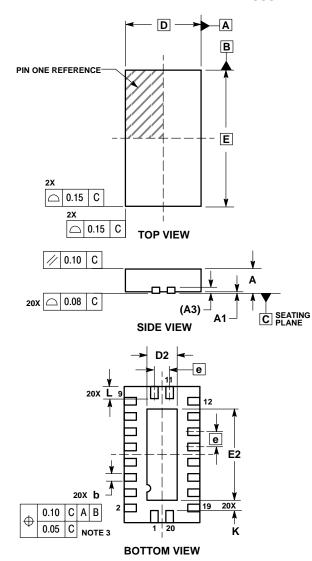
 DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION. SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL

B     4.30     4.50     0.169     0.177       C      1.20      0.047       D     0.05     0.15     0.002     0.006       F     0.50     0.75     0.002     0.030       G     0.65 BSC     0.026 BSC     H     0.27     0.37     0.011     0.015       J     0.09     0.20     0.004     0.008     0.008     0.008	CHES	INC	IETERS	MILLIN	
B     4.30     4.50     0.169     0.177       C      1.20      0.047       D     0.05     0.15     0.002     0.006       F     0.50     0.75     0.020     0.030       G     0.65     BSC     0.026     BSC       H     0.27     0.37     0.011     0.015       J     0.09     0.20     0.004     0.008	MAX	MIN	MAX	MIN	DIM
C      1.20      0.047       D     0.05     0.15     0.002     0.006       F     0.50     0.75     0.020     0.030       G     0.65     BSC     0.026     BSC       H     0.27     0.37     0.011     0.015       J     0.09     0.20     0.004     0.008	0.260	0.252	6.60	6.40	Α
D     0.05     0.15     0.002     0.006       F     0.50     0.75     0.020     0.030       G     0.65 BSC     0.026 BSC     H       H     0.27     0.37     0.011     0.015       J     0.09     0.20     0.004     0.008	0.177	0.169	4.50	4.30	В
F     0.50     0.75     0.020     0.030       G     0.65 BSC     0.026 BSC       H     0.27     0.37     0.011     0.015       J     0.09     0.20     0.004     0.008	0.047		1.20		C
G     0.65     BSC     0.026     BSC       H     0.27     0.37     0.011     0.015       J     0.09     0.20     0.004     0.008	0.006	0.002	0.15	0.05	D
H     0.27     0.37     0.011     0.015       J     0.09     0.20     0.004     0.008	0.030	0.020	0.75	0.50	F
J 0.09 0.20 0.004 0.008	6 BSC	0.026	BSC	0.65	G
	0.015	0.011	0.37	0.27	Н
J1 0.09 0.16 0.004 0.006	0.008	0.004	0.20	0.09	J
	0.006	0.004	0.16	0.09	J1
K 0.19 0.30 0.007 0.012	0.012	0.007	0.30	0.19	K
K1 0.19 0.25 0.007 0.010	0.010	0.007	0.25	0.19	K1
L 6.40 BSC 0.252 BSC		0.252	BSC		L
M 0° 8° 0° 8°	8°	0°	8°	0°	M

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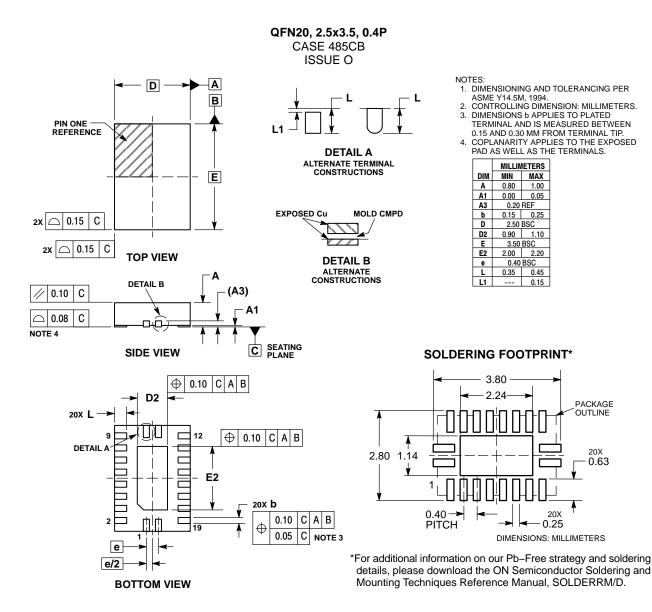
QFN20, 2.5x4.5 MM CASE 485AA ISSUE B



NOTES:
DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
CONTROLLING DIMENSION: MILLIMETERS.
DIMENSIONS b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM TERMINAL.
COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS		
DIM	MIN	MAX	
Α	0.80	1.00	
A1	0.00	0.05	
A3	0.20 REF		
b	0.20	0.30	
D	2.50 BSC		
D2	0.85	1.15	
E	4.50 BSC		
E2	2.85	3.15	
е	0.50 BSC		
K	0.20		
L	0.35	0.45	

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